## Notice of References Cited Application/Control No. 10/768,332 Examiner David A. Redding Applicant(s)/Patent Under Reexamination YONEKAWA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,843,767	12-1998	Beattie, Kenneth L.	435/287.1
*	В	US-6,345,115	02-2002	Ramm et al.	382/133
*	С	US-6,587,197	07-2003	Rahbar-Dehghan, Fariborz	356/318
*	D	US-6,643,010	11-2003	Rahbar-Dehghan, Fariborz	356/244
*	Е	US-6,676,904	01-2004	Lee et al.	422/101
*	F	US-6,713,309	03-2004	Anderson et al.	436/518
*	G	US-6,872,531	03-2005	Hosoi, Yuichi	435/6
*	Н	US-6,893,816	05-2005	Beattie, Kenneth L.	435/6
*	ı	US-2003/0096268	05-2003	Weiner et al.	435/6
*	J	US-2004/0137604	07-2004	Goodman et al.	435/287.2
*	K	US-2005/0285049	12-2005	Montagu et al.	250/458.1
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.